Controlling for confounders through approximate sufficiency

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Classical (parametric) approach:

- Assume a parametric model such as $Y \mid X, Z \sim f(\cdot; \alpha^{\top}X + \beta^{\top}Z)$
- Parametric inference to test $H_0: \alpha = 0$



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Model-X approach a.k.a. Conditional Randomization Test (Candès et al 2018)

- Known distribution of $X \mid Z$ (distrib. of Y unknown)
- Choose function T(X; Y, Z) that measures association
- Resample copies $ilde{X}^{(1)}, \ldots, ilde{X}^{(M)} \stackrel{\mathrm{iid}}{\sim} (\mathsf{distrib.} \text{ of } X \mid Z)$

$$\rightsquigarrow \quad \mathsf{pval} = \frac{1 + \sum_m \mathbb{1}\{T(\tilde{X}^{(m)}; Y, Z) \ge T(X; Y, Z)\}}{1 + M}$$

confounders Z? features X response Y



Model-X approach via sufficient statistics (Huang & Janson 2019)

- Distribution of $X \mid Z$ is only partially known
- By conditioning on sufficient statistic S(X, Z), can resample copies $\tilde{X}^{(1)}, \ldots, \tilde{X}^{(M)} \stackrel{\text{iid}}{\sim} (\text{distrib. of } X \mid S(X, Z))$ & compute p-value for test statistic T as before



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- Example: canonical GLMs

-
$$X_i \sim \exp \{X_i \cdot Z_i^\top \theta - a(Z_i^\top \theta)\}, i = 1, ..., n, \text{ with } \theta \text{ unknown}$$

- $S(X, Z) = \sum_i X_i Z_i \text{ is suff. stat. for } X = (X_1, ..., X_n)$

More generally...

Goodness-of-fit test Testing H_0 : $X \sim P_{\theta}$ for some $\theta \in \Theta$, where $\{P_{\theta} : \theta \in \Theta\}$ is a parametric family More generally...

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Conditional independence testing can be a special case:

- Assume $X \mid Z \sim P_{\theta}(\cdot \mid Z)$ for some $\theta \in \Theta$
- Null hypothesis H_0 : $X \perp Y \mid Z$
- Equivalently... $H_0: X \mid Y, Z \sim P_{\theta}(\cdot | Z)$ for some $\theta \in \Theta$
- Note: we condition on Y and Z (i.e., treat as fixed)

Intro: testing goodness-of-fit (GoF)

A general framework:

- Choose any test statistic $T: \mathcal{X} \to \mathbb{R}$
- Draw copies $ilde{X}^{(1)}, \dots, ilde{X}^{(M)}$
- Compute rank-based p-value

$$\mathsf{pval} = \frac{1 + \sum_m \mathbb{1}\{T(\tilde{X}^{(m)}) \ge T(X)\}}{1 + M}$$

• If $X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}$ are exchangeable under $H_0 \rightsquigarrow$ p-value is valid

Co-sufficient sampling

Sample copies $\tilde{X}^{(m)} \sim$ (distrib. of $X \mid S(X)$), where S(X) is a sufficient statistic for the family $\{P_{\theta} : \theta \in \Theta\}$

Can be applied to:

1. Test goodness-of-fit (GoF)

(Engen & Lillegård 1997, Lockhart et al 2007, Stephens 2012, Hazra 2013)

2. Test conditional independence (special case of GoF)

(Rosenbaum 1984, Kolassa 2003, Huang & Janson 2019)

 Construct conf. intervals for a parameter of interest (by inverting GoF tests)

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Permutation tests are an example of CSS

- $H_0: X_1, \ldots, X_n \stackrel{\text{iid}}{\sim} \mathcal{D} \text{ for } \mathcal{D} \in (\text{some set})$
- The order statistics $X_{(1)} \leq \cdots \leq X_{(n)}$ are sufficient under the null
- Permutation test \Leftrightarrow resampling X conditional on order statistics
- Application: testing X ⊥ Y
 H₀: conditional on Y₁,..., Y_n, it holds that X₁,..., X_n are i.i.d.

Limitation of co-sufficient sampling... no power in many settings!

Example—logistic model:

• $X = (X_1, ..., X_n) \in \{0, 1\}^n, Z = (Z_1, ..., Z_n) \in (\mathbb{R}^k)^n$

• If the Z_i 's are in general position, then $\sum_i X_i Z_i \in \mathbb{R}^k$ uniquely determines X

(so if we resample, will have $\widetilde{X}^{(1)} = \cdots = \widetilde{X}^{(M)} = X \rightsquigarrow$ zero power)

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For many other models, the minimal sufficient statistic S(X) is essentially the data itself, e.g.,

- Mixture of Gaussians or mixture of GLMs
- Non-canonical GLMs
- Heavy tailed distributions (e.g., multivariate t)
- Models with missing or corrupted data

For a family $\{P_{\theta} : \theta \in \Theta\}$, a function S(X) is a *sufficient statistic* if (distrib. of $X \mid S(X), X \sim P_{\theta}$) = (distrib. of $X \mid S(X), X \sim P_{\theta'}$) $\forall \theta, \theta'$.

Asymptotic sufficiency: (Le Cam, Wald, ...) Informally...

(distrib. of $X \mid S(X), X \sim P_{\theta}$) \approx (distrib. of $X \mid S(X), X \sim P_{\theta'}$) $\forall \theta, \theta'$.

• Under regularity conditions, $S(X) = \widehat{\theta}_{MLE}(X)$ is asymp. suff.

Main idea:

- Let $\widehat{ heta} \in \Theta$ be an approximate MLE given the data X
- Let $p_{\theta}(\cdot | \hat{\theta}) = \text{distrib. of } X | \hat{\theta}$, if marginally $X \sim P_{\theta}$ \rightsquigarrow under the null, $X | \hat{\theta} \sim p_{\theta_0}(\cdot | \hat{\theta})$ for the unknown true θ_0

• Sample copies
$$\tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}$$
 from $\underbrace{p_{\widehat{\theta}}(\cdot | \widehat{\theta}) \approx p_{\theta_0}(\cdot | \widehat{\theta})}_{\text{by approx. sufficiency}}$

 $X, ilde{X}^{(1)}, \dots, ilde{X}^{(M)} pprox$ exchangeable under $H_0 \rightsquigarrow$ p-value is pprox valid

Approximate co-sufficient sampling (aCSS)

Distance to exchangeability

$$\mathsf{d}_{\mathsf{exch}}(X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}) = \inf_{\substack{\mathsf{Exch. distrib.}\\ \mathcal{D} \text{ on } \mathcal{X}^{M+1}}} \left\{ \mathsf{d}_{\mathsf{TV}}\Big((X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}), \mathcal{D} \Big) \right\}$$

For any test statistic T(X), the p-value

$$\mathsf{pval} = \frac{1 + \sum_m \mathbb{1}\{T(\tilde{X}^{(m)}) \ge T(X)\}}{1 + M}$$

satisfies

$$\mathbb{P}\left\{\mathsf{pval} \le \alpha\right\} \le \alpha + \mathsf{d}_{\mathsf{exch}}(X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}).$$

- Step 1: choose a test statistic $T : \mathcal{X} \to \mathbb{R}$
- Step 2: observe data X, and compute an approximate MLE $\widehat{ heta}$
- Step 3: sample copies $ilde{X}^{(1)},\ldots, ilde{X}^{(M)}$ from pprox distribution of $X\mid\widehat{ heta}$
- Step 4: compute a rank-based p-value to test H_0 :

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• Step 2: observe data X, and compute an approximate MLE $\widehat{\theta}$

Ideally would like to minimize

$$\mathcal{L}(\theta; X, W) = \underbrace{\mathcal{L}(\theta; X)}_{\substack{\text{penalized neg. log-likelihood \\ -\log f(X; \theta) + \mathcal{R}(\theta)}} + \underbrace{\sigma \cdot W^{\top} \theta}_{\substack{\text{perturb with } W \sim \mathcal{N}(0, \frac{1}{d} I_d)}}_{\substack{\text{(choose } \sigma \ll n^{1/2})}}$$

(see also Tian & Taylor 2018—random perturbation for selective inference)

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(see also Tian & Taylor 2018-random perturbation for selective inference)

But... what if nonconvex? what if no global minimum?

- Function $\widehat{\theta} : \mathcal{X} \times \mathbb{R}^d \to \Theta$, returns $\widehat{\theta}(X, W)$.
- If $\hat{\theta}(X, W)$ is a strict SOSP of $\mathcal{L}(\theta; X, W)$, proceed to next step.
- Otherwise return $\tilde{X}^{(1)} = \cdots = \tilde{X}^{(M)} = X \rightsquigarrow \text{pval} = 1.$

aCSS algorithm

• Step 3: sample copies $ilde{X}^{(1)}, \dots, ilde{X}^{(M)}$ from pprox distribution of $X \mid \widehat{ heta}$

aCSS algorithm

• Step 3: sample copies $\tilde{X}^{(1)}, \ldots, \tilde{X}^{(M)}$ from \approx distribution of $X \mid \hat{\theta}$

Density of $X \mid \hat{\theta}$, conditional on the event that $\hat{\theta}(X, W)$ is strict SOSP: $\propto f(x;\theta_0) \cdot \exp\left\{-\frac{\|\nabla_{\theta}\mathcal{L}(\widehat{\theta};x)\|}{2\sigma^2/d}\right\} \cdot \det\left(\nabla_{\theta}^2\mathcal{L}(\widehat{\theta};x)\right) \cdot \mathbb{1}_{x \in \mathcal{X}_{\widehat{\theta}}}$

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If sampling directly is impossible,

can use an exchangeable form of MCMC (Besag & Clifford 1989)

Assumption 1: regularity conditions

- $\Theta \subseteq \mathbb{R}^d$ convex & open
- P_{θ} has positive density $f(\cdot; \theta)$ w.r.t. base measure $\nu_{\mathcal{X}}$ for all $\theta \in \Theta$
- Log-likelihood log $f(x; \theta)$ & penalty $\mathcal{R}(\theta)$ are continuously twice diff.

Assumption 2: approximate MLE For $X \sim P_{\theta_0}$ and $W \sim \mathcal{N}(0, \frac{1}{d}I_d)$, with prob. at least $1 - \delta$, $\|\widehat{\theta}(X, W) - \theta_0\| \leq r$ and $\widehat{\theta}(X, W)$ is a strict SOSP of $\mathcal{L}(\theta; X, W)$.

Assumption 3: Hessian of the log-likelihood

$$\mathbb{E}\left[\exp\left\{\sup_{\theta\in\mathbb{B}(\theta_{0},r)\cap\Theta}r^{2}\|\nabla^{2}\log f(X;\theta)-\mathbb{E}\left[\nabla^{2}\log f(X;\theta)\right]\|\right\}\right]\leq e^{\varepsilon}$$

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In standard settings with n independent observations...

$$r, \varepsilon, \delta = \widetilde{\mathcal{O}}(n^{-1/2})$$

Type I error guarantee

Theorem

Under Assumptions 1, 2, & 3, the copies produced by aCSS satisfy

$$\mathsf{d}_{\mathsf{exch}}(X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}) \leq 3\sigma r + \delta + \varepsilon$$

under H_0 .

Therefore, for any test statistic T, Type I error for testing H_0 satisfies

$$\mathbb{P}\left\{\mathsf{pval} \le \alpha\right\} \le \alpha + 3\sigma r + \delta + \varepsilon$$

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Excess Type I error should be o(1)...

- $r, \delta, \varepsilon \asymp n^{-1/2}$ from the assumptions
- σ = noise level, chosen by analyst \rightarrow choose $\sigma \asymp n^c$ for some $c \in [0, \frac{1}{2})$

Examples where CSS has no power, but aCSS assumptions hold:

• Canonical GLMs such as logistic regression (low-dim.):

$$X_i \stackrel{\mathbb{L}}{\sim} \operatorname{Bernoulli}\left(rac{e^{Z_i^ op eta}}{1+e^{Z_i^ op eta}}
ight)$$
 for unknown eta

• Two-sample difference-of-means (the Behrens–Fisher problem):

$$X_i \stackrel{ ext{iid}}{\sim} \mathcal{N}(\mu_X, \sigma_X^2), \quad Y_i \stackrel{ ext{iid}}{\sim} \mathcal{N}(\mu_Y, \sigma_Y^2), \quad ext{ test } H_0: \mu_X = \mu_Y$$

(An aCSS-like approach for this problem was considered by Lillegård 2001)

Examples where CSS has no power, but aCSS assumptions hold:

• Spatial process on integer lattice: for unknown ρ ,

 $X \sim \mathcal{N}(0, \Sigma)$ where $\Sigma_{ij} =
ho^{D_{ij}}$ for known pairwise distances D_{ij}

• Multivariate t distribution (low-dim.):

 $X_i \stackrel{\mathrm{iid}}{\sim} t_{\gamma}(0, \Sigma)$ for known γ & unknown Σ

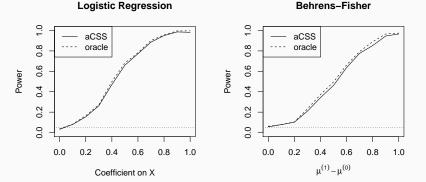
And maybe missing data, latent variables, and more ...

Compare to oracle method that knows θ_0 :

- Sample copies $\tilde{X}^{(m)} \stackrel{\mathrm{iid}}{\sim} P_{\theta_0}$
- Compute p-value with same statistic T(x)

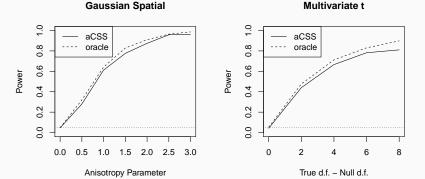
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Sampling

Recall: need to sample copies $\tilde{X}^{(m)}$ from

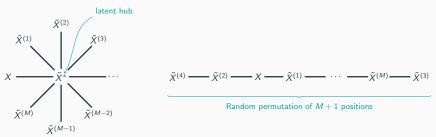
$$\propto f(x;\widehat{\theta}) \cdot \exp\left\{-\frac{\|\nabla_{\theta}\mathcal{L}(\widehat{\theta};x)\|}{2\sigma^2/d}\right\} \cdot \det\left(\nabla_{\theta}^2\mathcal{L}(\widehat{\theta};x)\right) \cdot \mathbb{1}_{x \in \mathcal{X}_{\widehat{\theta}}}$$

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Recall: need to sample copies $\tilde{X}^{(m)}$ from

$$\propto f(x;\widehat{\theta}) \cdot \exp\left\{-\frac{\|\nabla_{\theta}\mathcal{L}(\widehat{\theta};x)\|}{2\sigma^2/d}\right\} \cdot \det\left(\nabla_{\theta}^2\mathcal{L}(\widehat{\theta};x)\right) \cdot \mathbb{1}_{x \in \mathcal{X}_{\widehat{\theta}}}$$

Two exchangeable MCMC strategies (Besag & Clifford 1989)



- Run Metropolis–Hastings, where $f(x; \hat{\theta})$ stationary for proposal distrib.
- e.g., if X consists of n indep. observations (i.e., f(x; θ̂) = ∏ⁿ_{i=1} f_i(x_i; θ̂)), can choose proposal distrib. = resample s of n observations

Need to bound $d_{exch}(X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)})$

(1) Calculate joint distribution:

$$egin{array}{lll} \widehat{ heta} & \sim (ext{marginal distrib. of } \widehat{ heta}) \ X \mid \widehat{ heta} & \sim p_{ heta_0}(\cdot \mid \widehat{ heta}) \ \widetilde{X}^{(m)} \mid X, \widehat{ heta} & \sim p_{\widehat{ heta}}(\cdot \mid \widehat{ heta}) \end{array}$$

 $\implies \mathsf{d}_{\mathsf{exch}}(X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}) \leq \mathbb{E}_{\widehat{\theta}}\left[\mathsf{d}_{\mathsf{TV}}(p_{\theta_0}(\cdot | \widehat{\theta}), p_{\widehat{\theta}}(\cdot | \widehat{\theta}))\right]$

(2) To bound d_{TV} :

$$\frac{p_{\widehat{\theta}}(X|\widehat{\theta})}{p_{\theta_0}(X|\widehat{\theta})} \propto \frac{f(X;\widehat{\theta})}{f(X;\theta_0)} \quad \Rightarrow \quad \frac{p_{\widehat{\theta}}(X|\widehat{\theta})}{p_{\theta_0}(X|\widehat{\theta})} = \frac{\frac{f(X;\theta)}{f(X;\theta_0)}}{\mathbb{E}_{p_{\theta_0}(\cdot|\widehat{\theta})}\left[\frac{f(X;\widehat{\theta})}{f(X;\theta_0)}\right]}$$

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$$\frac{p_{\widehat{\theta}}\left(X|\widehat{\theta}\right)}{p_{\theta_{0}}\left(X|\widehat{\theta}\right)} \propto \frac{f(X;\widehat{\theta})}{f(X;\theta_{0})} \quad \Rightarrow \quad \frac{p_{\widehat{\theta}}\left(X|\widehat{\theta}\right)}{p_{\theta_{0}}\left(X|\widehat{\theta}\right)} = \frac{\frac{f(X;\widehat{\theta})}{f(X;\theta_{0})}}{\mathbb{E}_{\rho_{\theta_{0}}\left(\cdot|\widehat{\theta}\right)}\left[\frac{f(X;\widehat{\theta})}{f(X;\theta_{0})}\right]}$$
$$\Rightarrow \quad \mathsf{d}_{\mathsf{TV}}\left(p_{\theta_{0}}\left(\cdot|\widehat{\theta}\right), p_{\widehat{\theta}}\left(\cdot|\widehat{\theta}\right)\right) = \mathbb{E}_{\rho_{\theta_{0}}\left(\cdot|\widehat{\theta}\right)}\left[\left(1 - \frac{\frac{f(X;\widehat{\theta})}{f(X;\theta_{0})}}{\mathbb{E}_{\rho_{\theta_{0}}\left(\cdot|\widehat{\theta}\right)}\left[\frac{f(X;\widehat{\theta})}{f(X;\theta_{0})}\right]}\right)_{+}\right]$$

So, we need to show that $\frac{f(X;\widehat{ heta})}{f(X;\theta_0)}$ is \approx constant over distrib. $X|\widehat{ heta}$.

Proof sketch for Theorem

$$\log\left(\frac{f(X;\widehat{\theta})}{f(X;\theta_0)}\right) = -(\theta_0 - \widehat{\theta})^\top \nabla_\theta \log f(X;\widehat{\theta}) - \frac{1}{2}(\theta_0 - \widehat{\theta})^\top \nabla_\theta^2 \log f(X;\widetilde{\theta})(\theta_0 - \widehat{\theta})$$

Proof sketch for Theorem

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$$\log\left(\frac{f(X;\widehat{\theta})}{f(X;\theta_{0})}\right) = -(\theta_{0}-\widehat{\theta})^{\top}\nabla_{\theta}\log f(X;\widehat{\theta}) - \frac{1}{2}(\theta_{0}-\widehat{\theta})^{\top}\nabla_{\theta}^{2}\log f(X;\widetilde{\theta})(\theta_{0}-\widehat{\theta})$$

$$\implies \left|\log\left(\frac{f(X;\widehat{\theta})}{f(X;\theta_{0})}\right) + \frac{1}{2}(\theta_{0}-\widehat{\theta})^{\top}\mathbb{E}_{\theta_{0}}\left[\nabla_{\theta}^{2}\log f(X;\widetilde{\theta})\right](\theta_{0}-\widehat{\theta})\right|$$

$$\leq r \cdot \left\|\nabla_{\theta}\log f(X;\widehat{\theta})\right\| + \frac{1}{2} \cdot r^{2} \left\|\nabla_{\theta}^{2}\log f(X;\widetilde{\theta}) - \mathbb{E}_{\theta_{0}}\left[\nabla_{\theta}^{2}\log f(X;\widetilde{\theta})\right]\right\|$$

$$\approx \varepsilon \text{ by Asm. 3}$$

$$\implies \text{ th prob. } \geq 1 - \delta \text{ by Asm. 2}$$

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$$\leq r \cdot \left\|\nabla_{\theta}\log f(X;\widehat{\theta})\right\| + \frac{1}{2} \cdot \frac{r^{2}\left\|\nabla_{\theta}^{2}\log f(X;\widetilde{\theta}) - \mathbb{E}_{\theta_{0}}\left[\nabla_{\theta}^{2}\log f(X;\widetilde{\theta})\right]\right\|}{\approx \varepsilon \text{ by Asm. 3}}$$

$$= \sigma \|W\| \approx \sigma$$

$$\approx \delta \text{ by Asm. 2}$$

Rearrange \rightsquigarrow $\mathsf{d}_{\mathsf{exch}}(X, \tilde{X}^{(1)}, \dots, \tilde{X}^{(M)}) \leq \mathbb{E}_{\widehat{\theta}}\left[\mathsf{d}_{\mathsf{TV}}\big(p_{\theta_0}(\cdot | \widehat{\theta}), p_{\widehat{\theta}}\left(\cdot | \widehat{\theta}\right)\big)\right] \leq 3\sigma r + \delta + \varepsilon$

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- How to choose σ to balance Type I error & power?
- Connections to Bayesian methods?
- Apply to high dimensional regression / covariance estimation?
- Apply to missing data / latent variables / models with singularities?
- Extend to model-X knockoffs?